

FQD6P25-VB Datasheet

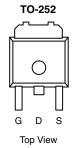
Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 250				
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	1.0			
Q _g (Max.) (nC)	38				
Q _{gs} (nC)	8.0				
Q _{gd} (nC)	18				
Configuration	Single				

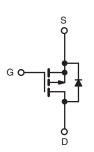
FEATURES

- · Advanced Process Technology
- Dynamic dV/dt Rating
- 150 °C Operating Temperature
- · Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead (Pb)-free Available





Drain Connected to Tab



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 250	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V_{GS} at - 10 V $\frac{T_C = 25}{T_C = 100}$	$T_C = 25 ^{\circ}C$		- 6.0		
	VGS at - 10 V	$T_C = 100 ^{\circ}C$	I _D	- 4.0	Α	
Pulsed Drain Current ^a			I_{DM}	- 16		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	520	mJ	
Repetitive Avalanche Currenta			I _{AR}	- 4.1	Α	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$		P_{D}	85	W		
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Forque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 62 mH, R_G = 25 Ω , I_{AS} = 4.1 A (see fig. 12). c. I_{SD} \leq 4.1 A, dI/dt \leq 640 A/ μ s, V_{DD} \leq V_{DS}, T_J \leq 150 °C. d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	=	3.6	C/VV		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		- 250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	- 0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zava Cata Valtaria Brain Comment		V _{DS} = - 250 V, V _{GS} = 0 V		-	-	- 25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 200	V, V _{GS} = 0 V, T _J = 150 °C	-	-	- 250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 2.5 A ^b	-	1.0	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	- 50 V, I _D = - 4.1 A ^b	2.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,		680	-	
Output Capacitance	C _{oss}		$V_{DS} = -25 V,$	-	170	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	40	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Q_g			ı	-	38	
Gate-Source Charge	Q_{gs}	V _{GS} = - 10 V	$I_D = -4.1 \text{ A}, V_{DS} = -200 \text{ V},$ see fig. 6 and 13 ^b	1	-	8.0	nC
Gate-Drain Charge	Q_{gd}		gramma va	-	-	18	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = -130 \text{ V}, I_D = -4.1 \text{ A},$ $R_G = 12 \Omega, R_D = 31 \Omega,$ see fig. 10^b		-	12	-	- ns
Rise Time	t _r			-	23	-	
Turn-Off Delay Time	t _{d(off)}			-	34	-	
Fall Time	t _f				21	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	ml l
Internal Source Inductance	L _S			-	7.5	-	– nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		i	-	- 4.1	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 16	
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$T_J = 25 ^{\circ}\text{C}, I_S = -4.1 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	- 6.5	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = - 4.1 A, dl/dt = -100 A/μs ^b		-	190	290	ns
Body Diode Reverse Recovery Charge	Q_{rr}			-	1.5	2.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)				_D)	

Notes

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- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

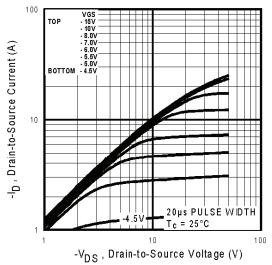


Fig. 1 - Typical Output Characteristics, T_C = 25 $^{\circ}C$

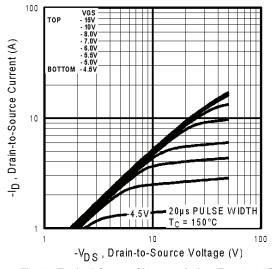


Fig. 2 - Typical Output Characteristics, T $_{\text{C}}\text{=}$ 150 $^{\circ}\text{C}$

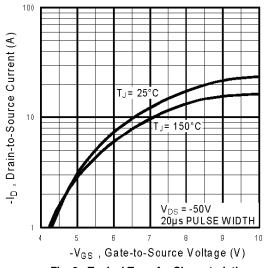


Fig. 3 - Typical Transfer Characteristics

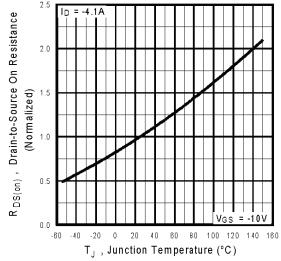


Fig. 4 - Normalized On-Resistance vs. Temperature



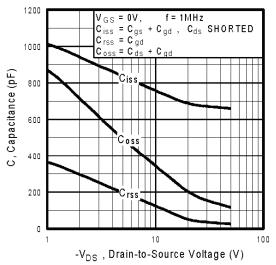


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

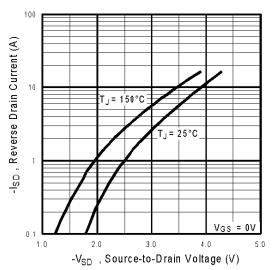


Fig. 7 - Typical Source-Drain Diode Forward Voltage

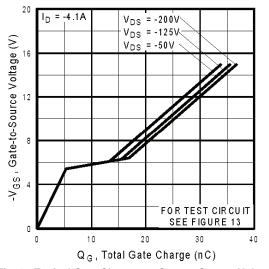


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

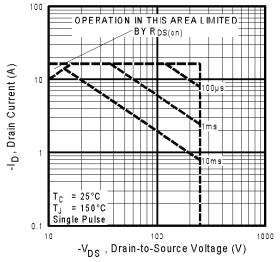


Fig. 8 - Maximum Safe Operating Area



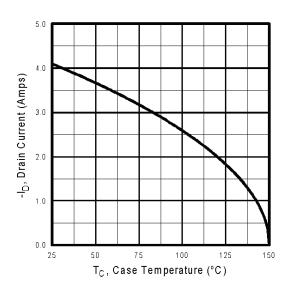


Fig. 9 - Maximum Drain Current vs. Case Temperature

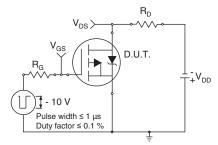


Fig. 10a - Switching Time Test Circuit

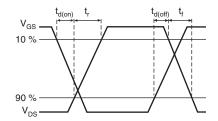


Fig. 10b - Switching Time Waveforms

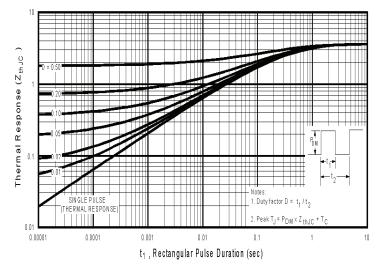
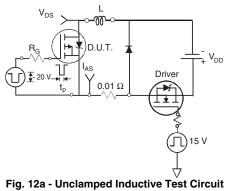


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



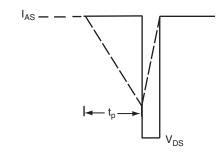


Fig. 12b - Unclamped Inductive Waveforms



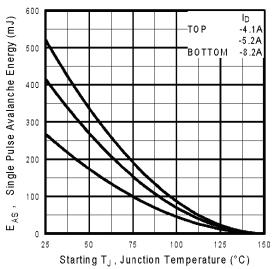


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

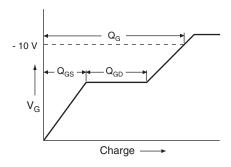


Fig. 13a - Basic Gate Charge Waveform

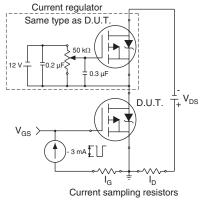
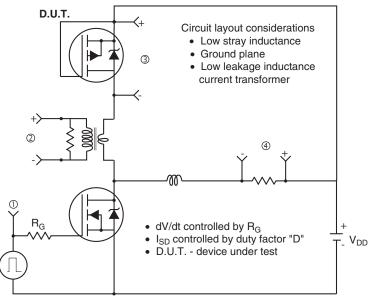


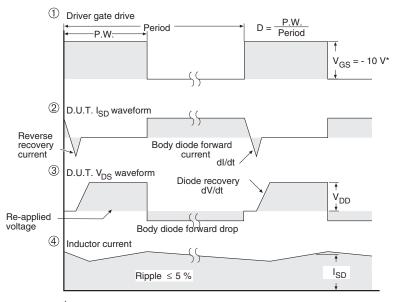
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

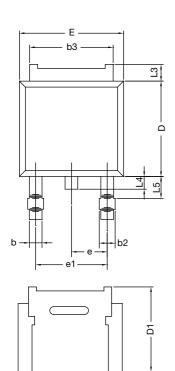


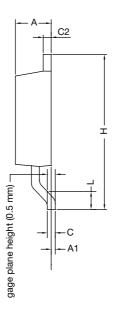
* $V_{GS} = -5 \text{ V}$ for logic level and -3 V drive devices

Fig. 14 - For P-Channel



TO-252AA CASE OUTLINE





	MILLIN	METERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	=	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

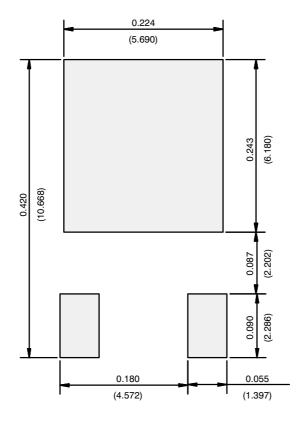
Note

• Dimension L3 is for reference only.



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RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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